20 🛛 V_{CC}

19 1 OE

18 🛛 B₀

17 🛛 B₁

16 **B**₂

15 B₃

14 🛛 B₄

13 B5

12 🛛 B₆

11 B7

P, Q, OR SO PACKAGE (TOP VIEW)

T/R

A₀ [] 2

A₁ [] 3

A₂ 🛛 4

A3 🛛 5

A₆ 🛛 8

A₇ [] 9

GND 110

6

A₄ [

A5

- Function and Pinout Compatible With FCT and F Logic
 25-Ω Output Series Resistors to Reduce Transmission-Line Reflection Noise
 Edge-Rate Control Circuitry for Significantly Improved Noise
- Characteristics
- I_{off} Supports Partial-Power-Down Mode Operation
- Fully Compatible With TTL Input and Output Logic Levels
- ESD Protection Exceeds JESD 22
 - 2000-V Human-Body Model (A114-A)
 - 200-V Machine Model (A115-A)
 - 1000-V Charged-Device Model (C101)
- 12-mA Output Sink Current
 15-mA Output Source Current
- 3-State Outputs

description

The CY74FCT2245T contains eight noninverting, bidirectional buffers with 3-state outputs intended for bus-oriented applications. On-chip termination resistors at the outputs reduce system noise caused by reflections. For this reason, the CY74FCT2245T can replace the CY74FCT245T in an existing design. The CY74FCT2245T current-sinking capability is 12 mA at the A and B ports.

The transmit/receive (T/R) input determines the direction of data flow through the bidirectional transceiver. Transmit (active high) enables data from A ports to B ports; receive (active low) enables data from B ports to A ports. The output-enable (\overline{OE}) input, when high, disables both the A and B ports by putting them in the high-impedance state.

This device is fully specified for partial-power-down applications using I_{off} . The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

TA	PACI	KAGE [†]	SPEED (ns)	ORDERABLE PART NUMBER	TOP-SIDE MARKING						
	QSOP – Q	Tape and reel	4.1	CY74FCT2245CTQCT	FCT2245						
	SOIC – SO	Tube	4.1	CY74FCT2245CTSOC	FCT2245						
	3010 - 30	Tape and reel	4.1	CY74FCT2245CTSOCT	FG12245						
	DIP – P	Tube	4.6	CY74FCT2245ATPC	74FCT2245ATPC						
–40°C to 85°C	QSOP – Q	Tape and reel	4.6	CY74FCT2245ATQCT	FCT2245A						
-40°C 10 85°C	SOIC – SO	Tube	4.6	CY74FCT2245ATSOC	FCT2245A						
	SUIC - SU	Tape and reel	4.6	CY74FCT2245ATSOCT	FC12245A						
	QSOP – Q	Tape and reel	7.0	CY74FCT2245TQCT	FCT2245						
	SOIC – SO	Tube	7.0	CY74FCT2245TSOC	FCT2245						
	3010 - 50	Tape and reel	7.0	CY74FCT2245TSOCT	FG12240						

ORDERING INFORMATION

[†] Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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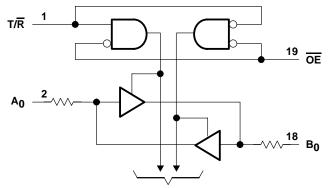
FUNCTION TABLE

INP	UTS	Ουτρυτ				
OE	T/R	001201				
L	L	Bus B data to bus A				
L	Н	Bus A data to bus B				
Н	Х	Z				

H = High logic level, L = Low logic level,

X = Don't care, Z = High-impedance state

logic diagram (positive logic)



To Seven Other Channels

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Supply voltage range to ground potential		
DC input voltage range		. –0.5 V to 7 V
DC output voltage range		. –0.5 V to 7 V
DC output current (maximum sink current/pin)		120 mA
Package thermal impedance, θ_{JA} (see Note 1):	: P package	69°C/W
	Q package	68°C/W
	SO package	58°C/W
Ambient temperature range with power applied	I, T _A	-65°C to 135°C
Storage temperature range, T _{stg}		-65°C to 150°C

[†] Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

recommended operating conditions (see Note 2)

		MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.75	5	5.25	V
VIH	High-level input voltage	2			V
V_{IL}	Low-level input voltage			0.8	V
ЮН	High-level output current			-15	mA
IOL	Low-level output current			12	mA
ТĄ	Operating free-air temperature	-40		85	°C

NOTE 2: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation.



CY74FCT2245T 8-BIT TRANSCEIVER WITH 3-STATE OUTPUTS

SCCS037B - JULY 1994 - REVISED NOVEMBER 2001

PARAMETER		TEST CONDITION	S	MIN	TYP†	MAX	UNIT
VIК	V _{CC} = 4.75,	I _{IN} = -18 mA			-0.7	-1.2	V
Vон	V _{CC} = 4.75,	I _{OH} = -15 mA		2.4	3.3		V
V _{OL}	V _{CC} = 4.75,	I _{OL} = 12 mA			0.3	0.55	V
R _{out}	V _{CC} = 4.75,	I _{OL} = 12 mA		20	25	40	Ω
V _{hys}	All inputs				0.2		V
lį	V _{CC} = 5.25 V,	$V_{IN} = V_{CC}$				5	μA
ЧΗ	V _{CC} = 5.25 V,	V _{IN} = 2.7 V				±1	μΑ
۱ _{IL}	V _{CC} = 5.25 V,	V _{IN} = 0.5 V				±1	μΑ
IOZH	V _{CC} = 5.25 V,	V _{OUT} = 2.7 V				10	μΑ
I _{OZL}	V _{CC} = 5.25 V,	V _{OUT} = 0.5 V				-10	μΑ
los‡	V _{CC} = 5.25 V,	V _{OUT} = 0 V		-60	-120	-225	mA
l _{off}	$V_{CC} = 0 V,$	V _{OUT} = 4.5 V			±1	μA	
ICC	V _{CC} = 5.25 V,	$V_{IN} \le 0.2 V$,	$V_{IN} \ge V_{CC} - 0.2 V$		0.1	0.2	mA
ΔICC	V _{CC} = 5.25 V, V _{IN} =	= 3.4 V§, f ₁ = 0, Outputs op	ben		0.5	2	mA
ICCD		input switching at 50% duty $N \le 0.2 \text{ V or } V_{IN} \ge V_{CC} - 100 \text{ V}$			0.06	0.12	mA MHz
		One input switching at f ₁ = 10 MHz	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		0.7	1.4	
I-#	$V_{CC} = 5.25 V,$	at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		1	2.4	mA
IC#	Outputs open, T/R = OE = GND	Eight bits switching at $f_1 = 2.5 \text{ MHz}$	$V_{IN} \le 0.2 \text{ V or}$ $V_{IN} \ge V_{CC} - 0.2 \text{ V}$		1.3	2.6	mA
		at 50% duty cycle	$V_{IN} = 3.4 \text{ V or GND}$		3.3	10.6ll	
Ci					5	10	pF
Co					9	12	pF

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

[†] Typical values are at V_{CC} = 5 V, T_A = 25°C.

* Not more than one output should be shorted at a time. Duration of short should not exceed one second. The use of high-speed test apparatus and/or sample-and-hold techniques are preferable to minimize internal chip heating and more accurately reflect operational values. Otherwise, prolonged shorting of a high output can raise the chip temperature well above normal and cause invalid readings in other parametric tests. In any sequence of parameter tests, IOS tests should be performed last.

§ Per TTL-driven input (V_{IN} = 3.4 V); all other inputs at V_{CC} or GND

This parameter is derived for use in total power-supply calculations.

 ${}^{\#}I_{C} = I_{CC} + \Delta I_{CC} \times D_{H} \times N_{T} + I_{CCD} (f_{0}/2 + f_{1} \times N_{1})$

Where:

I_C = Total supply current

ICC = Power-supply current with CMOS input levels

- ΔI_{CC} = Power-supply current for a TTL high input (VIN = 3.4 V)
- D_H = Duty cycle for TTL inputs high
- N_T = Number of TTL inputs at D_H

I_{CCD} = Dynamic current caused by an input transition pair (HLH or LHL)

- f_0 = Clock frequency for registered devices, otherwise zero
- f₁ = Input signal frequency
- N_1 = Number of inputs changing at f_1
- All currents are in milliamperes and all frequencies are in megahertz.

Il Values for these conditions are examples of the I_{CC} formula.



CY74FCT2245T **8-BIT TRANSCEIVER** WITH 3-STATE OUTPUTS SCCS037B – JULY 1994 – REVISED NOVEMBER 2001

switching characteristics over operating free-air temperature range (see Figure 1)

PARAMETER	FROM	TO (OUTPUT)	CY74FC	CY74FCT2245T		CY74FCT2245AT		CY74FCT2245CT		
FARAMETER	(INPUT)		MIN	MAX	MIN	MAX	MIN	MAX	UNIT	
^t PLH	A _n or B _n	R or ∧	1.5	7	1.5	4.6	1.5	4.1	ns	
^t PHL		B _n or A _n	1.5	7	1.5	4.6	1.5	4.1	115	
^t PZH	OE	A or B	1.5	9.5	1.5	6.2	1.5	5.8	ns	
^t PZL	OE		1.5	9.5	1.5	6.2	1.5	5.8		
^t PHZ	OE	A or B	1.5	7.5	1.5	5	1.5	4.5	ns	
^t PLZ	UE UE	AUB	1.5	7.5	1.5	5	1.5	4.5	115	



07V **S1** O Open **500** Ω From Output From Output Test $\Lambda \Lambda \Lambda$ TEST **S1** O GND **Under Test Under Test** Point Open tPLH/tPHL $C_L = 50 \text{ pF}$ $C_1 = 50 \text{ pF}$ 2 **500** Ω **500** Ω 7 V ^tPLZ^{/t}PZL (see Note A) (see Note A) tPHZ/tPZH Open LOAD CIRCUIT FOR LOAD CIRCUIT FOR **TOTEM-POLE OUTPUTS 3-STATE OUTPUTS** 3 V **Timing Input** 1.5 V 0 V tw th 3 V tsu 3 V 1.5 V 1.5 V Input 1.5 V 1.5 V **Data Input** 0 V 0 V **VOLTAGE WAVEFORMS VOLTAGE WAVEFORMS** PULSE DURATION SETUP AND HOLD TIMES 3 V 3 V Output 1.5 V 1.5 V 1.5 V 1.5 V Input Control 0 V 0 V -t_{PLZ} ^tPLH ^tPHL tPZL -₽ VOH Output ≈3.5 V In-Phase 1.5 V 1.5 V Waveform 1 .5 V Output V_{OL} + 0.3 V (see Note B) VOL VOL ^tPHL ^tPLH ^tPZH ^tPHZ ۷он Output ۷он **Out-of-Phase** VOH – 0.3 V 1.5 V 1.5 V Waveform 2 5 V Output (see Note B) ≈0 V VOL **VOLTAGE WAVEFORMS VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES** ENABLE AND DISABLE TIMES INVERTING AND NONINVERTING OUTPUTS LOW- AND HIGH-LEVEL ENABLING

PARAMETER MEASUREMENT INFORMATION

NOTES: A. C₁ includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms





11-Apr-2013

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings (4)	Samples
74FCT2245ATSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
74FCT2245ATSOCTG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
74FCT2245CTSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245C	Samples
74FCT2245CTSOCTG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245C	Samples
CY74FCT2245ATPC	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	74FCT2245ATPC	Samples
CY74FCT2245ATPCE4	ACTIVE	PDIP	Ν	20	20	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-40 to 85	74FCT2245ATPC	Samples
CY74FCT2245ATPWR	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FR245AT	Samples
CY74FCT2245ATPWRE4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FR245AT	Samples
CY74FCT2245ATPWRG4	ACTIVE	TSSOP	PW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FR245AT	Samples
CY74FCT2245ATQCT	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245A	Samples
CY74FCT2245ATQCTE4	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245A	Samples
CY74FCT2245ATQCTG4	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245A	Samples
CY74FCT2245ATSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
CY74FCT2245ATSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
CY74FCT2245ATSOCG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
CY74FCT2245ATSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245A	Samples
CY74FCT2245CTQCT	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245C	Samples



11-Apr-2013

Orderable Device	Status	Package Type	•	Pins	•	Eco Plan	Lead/Ball Finish	MSL Peak Temp	Op Temp (°C)	Top-Side Markings	Samples
	(1)		Drawing		Qty	(2)		(3)		(4)	
CY74FCT2245CTQCTE4	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245C	Samples
CY74FCT2245CTQCTG4	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245C	Samples
CY74FCT2245CTSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245C	Samples
CY74FCT2245TQCT	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245	Samples
CY74FCT2245TQCTG4	ACTIVE	SSOP	DBQ	20	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR	-40 to 85	FCT2245	Samples
CY74FCT2245TSOC	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples
CY74FCT2245TSOCE4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples
CY74FCT2245TSOCG4	ACTIVE	SOIC	DW	20	25	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples
CY74FCT2245TSOCT	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples
CY74FCT2245TSOCTE4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples
CY74FCT2245TSOCTG4	ACTIVE	SOIC	DW	20	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-40 to 85	FCT2245	Samples

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.

TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes. **Pb-Free (RoHS Exempt):** This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.



PACKAGE OPTION ADDENDUM

11-Apr-2013

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

⁽³⁾ MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ Multiple Top-Side Markings will be inside parentheses. Only one Top-Side Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Top-Side Marking for that device.

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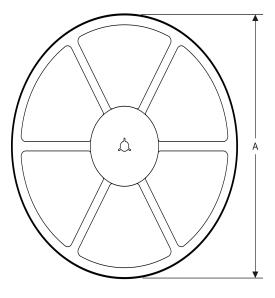
PACKAGE MATERIALS INFORMATION

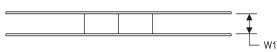
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TAPE AND REEL INFORMATION

REEL DIMENSIONS

Texas Instruments





TAPE AND REEL INFORMATION

TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

*All dimensions are nominal												
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CY74FCT2245ATPWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1
CY74FCT2245ATQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2245ATSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CY74FCT2245CTQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2245CTSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1
CY74FCT2245TQCT	SSOP	DBQ	20	2500	330.0	16.4	6.5	9.0	2.1	8.0	16.0	Q1
CY74FCT2245TSOCT	SOIC	DW	20	2000	330.0	24.4	10.8	13.0	2.7	12.0	24.0	Q1

TEXAS INSTRUMENTS

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PACKAGE MATERIALS INFORMATION

16-Aug-2012



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CY74FCT2245ATPWR	TSSOP	PW	20	2000	367.0	367.0	38.0
CY74FCT2245ATQCT	SSOP	DBQ	20	2500	367.0	367.0	38.0
CY74FCT2245ATSOCT	SOIC	DW	20	2000	367.0	367.0	45.0
CY74FCT2245CTQCT	SSOP	DBQ	20	2500	367.0	367.0	38.0
CY74FCT2245CTSOCT	SOIC	DW	20	2000	367.0	367.0	45.0
CY74FCT2245TQCT	SSOP	DBQ	20	2500	367.0	367.0	38.0
CY74FCT2245TSOCT	SOIC	DW	20	2000	367.0	367.0	45.0

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



NOTES:

- A. All linear dimensions are in inches (millimeters).B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- \triangle The 20 pin end lead shoulder width is a vendor option, either half or full width.



DW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).

D. Falls within JEDEC MS-013 variation AC.



LAND PATTERN DATA



NOTES:

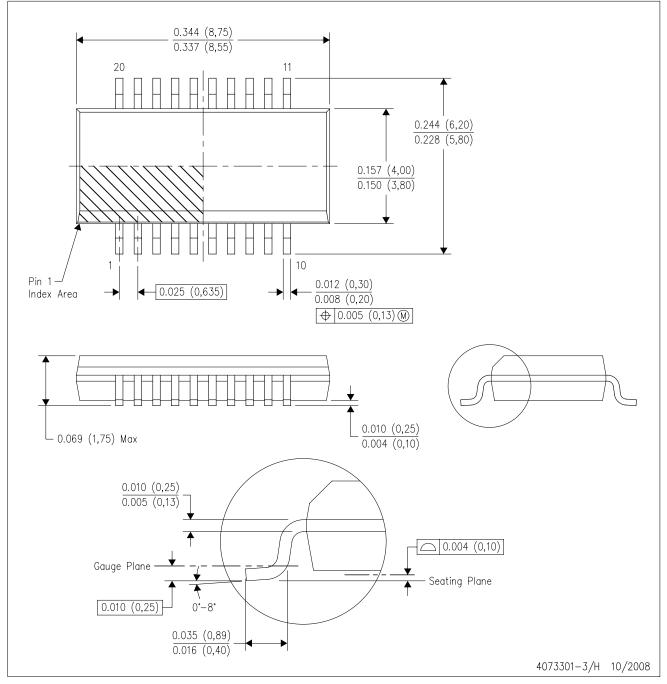
A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



DBQ (R-PDSO-G20)

PLASTIC SMALL-OUTLINE PACKAGE



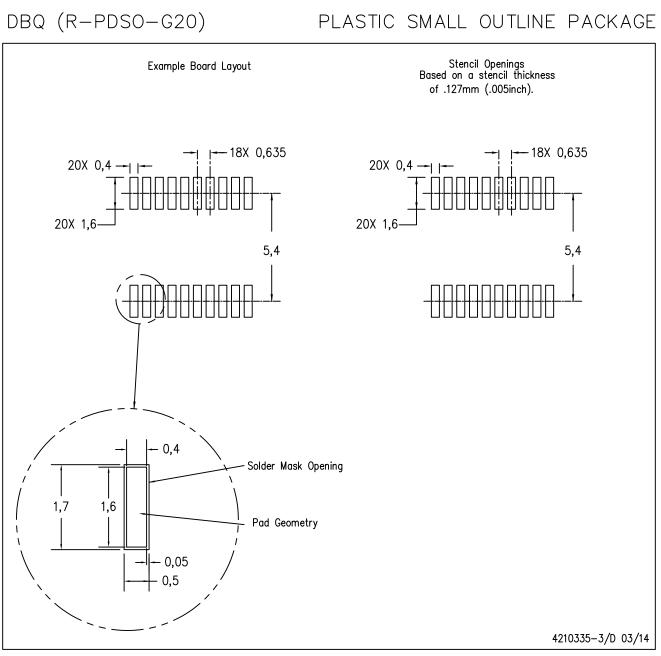
NOTES: A. All linear dimensions are in inches (millimeters).

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15) per side.

D. Falls within JEDEC MO-137 variation AD.





NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate designs.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



PW (R-PDSO-G20)

PLASTIC SMALL OUTLINE



NOTES:

A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M-1994. β . This drawing is subject to change without notice.

Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0,15 each side.

Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.

E. Falls within JEDEC MO-153





NOTES: A. All linear dimensions are in millimeters.

- B. This drawing is subject to change without notice.
- C. Publication IPC-7351 is recommended for alternate design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
 E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



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